Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/663,744	HUAPAYA, LUIS	
Examiner	Art Unit	_
Kieu D. Vu	2173	

SEARCHED			
Class	Subclass	Date	Examiner
715	804	6/7/2007	κv
715	802	6/7/2007	κv
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			!	

SEARCH (INCLUDING SEAF		')
	DATE	EXMR
East search (USPAT USPGPUB EPO JPO DERWENT IBM_TDB USOCR)	6/7/2007	κv